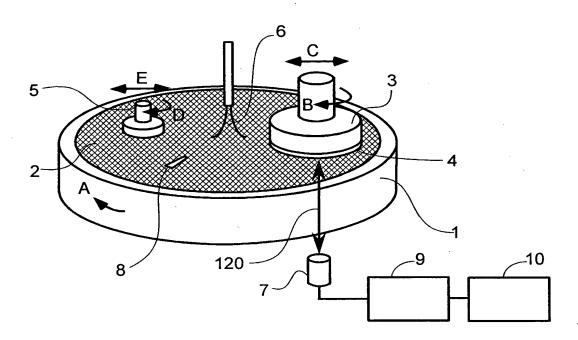
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"Method and Apparatus for Measuring Thickness of Thin Film and Device Manufacturing Method Using Same"

Attorney Docket No. 16869P-041600US

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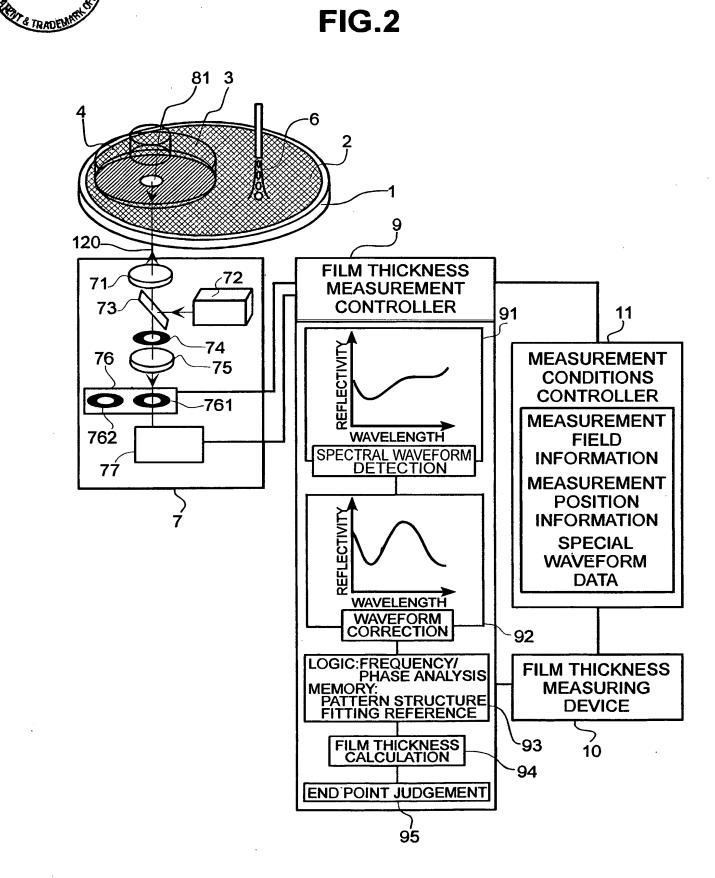
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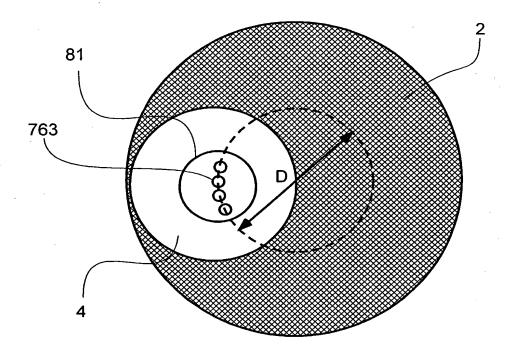


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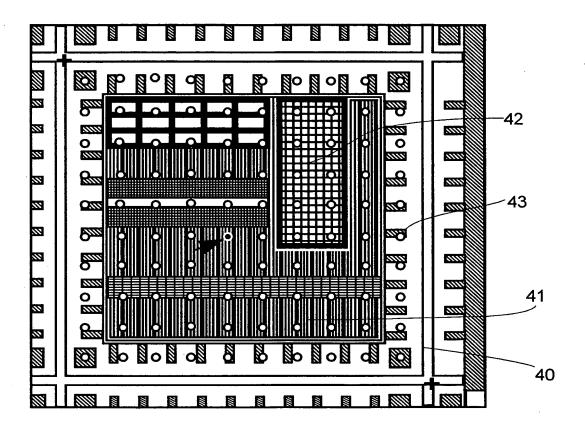
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FIG.5

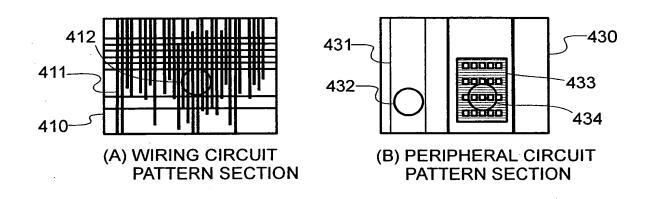
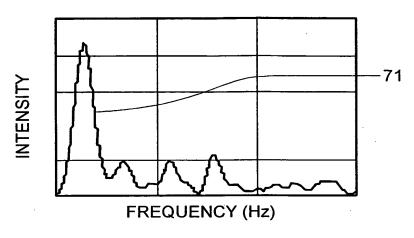


FIG.6 63 62 REFLECTIVITY 600 61 400 500 600 800 700 WAVELENGTH (nm)

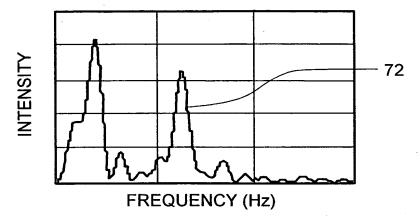
Application No. 10/082,520 Mineo NOMOTO, et al. "Method and Apparatus for Measuring Thickness of Thin Film and Device Manufacturing Method Using Same" Attorney Docket No. 16869P-041600US . Colwell, Reg. No. 27,431 (650) 326-2400

Robert C. Colwell, Reg. No. 27,431

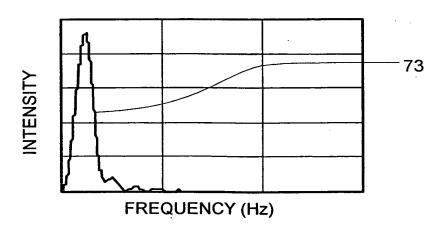
FIG.7



### (a) WIRING CIRCUIT SECTION



### (b) MEMORY CIRCUIT SECTION



(c) PERIPHERAL CIRCUIT SECTION

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FIG.8

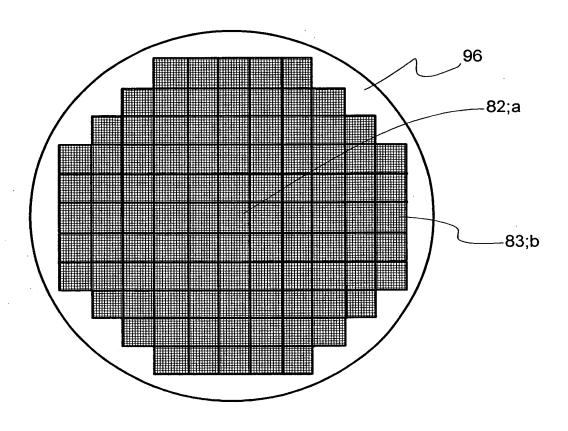


FIG.9 92 91 93 95 (a)

(b)

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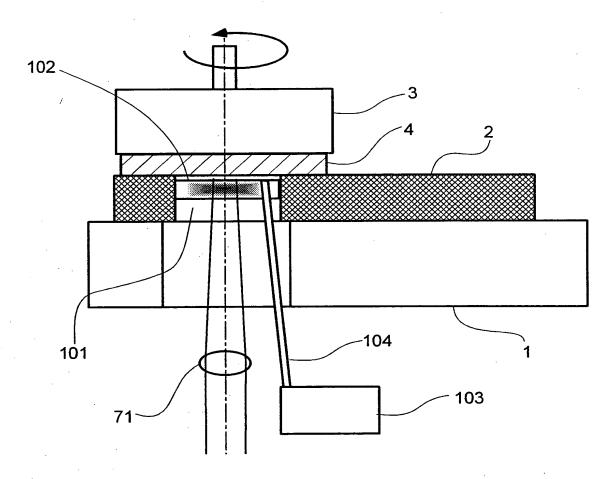
Application No. 10/082,520

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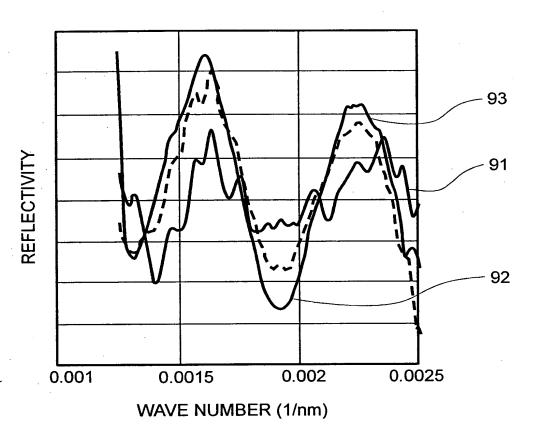
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**FIG.10** 





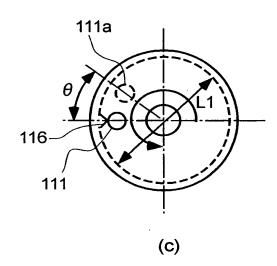
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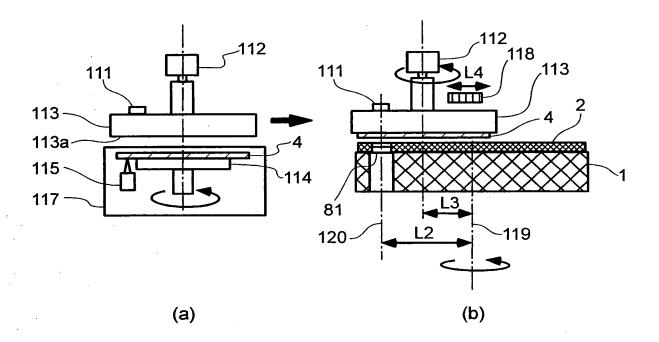


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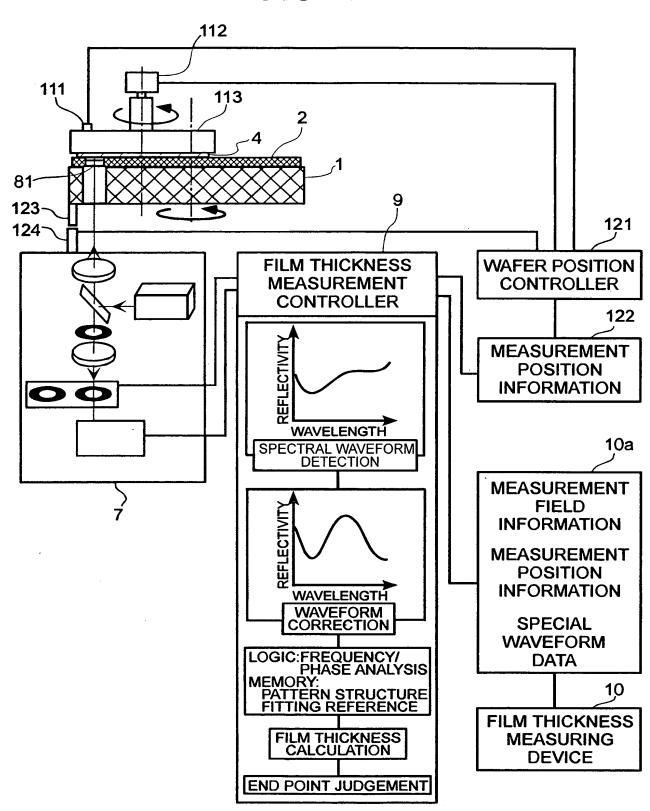
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(650) 326-2400



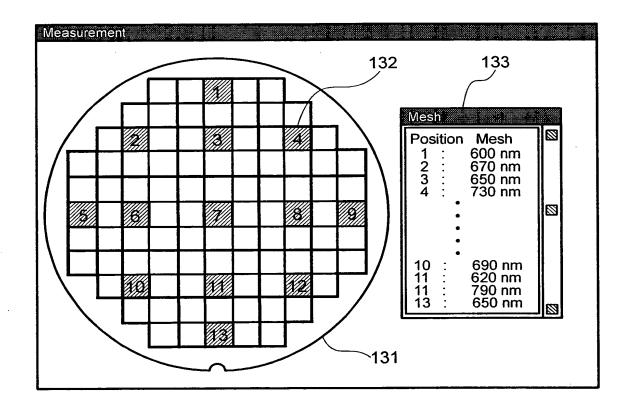


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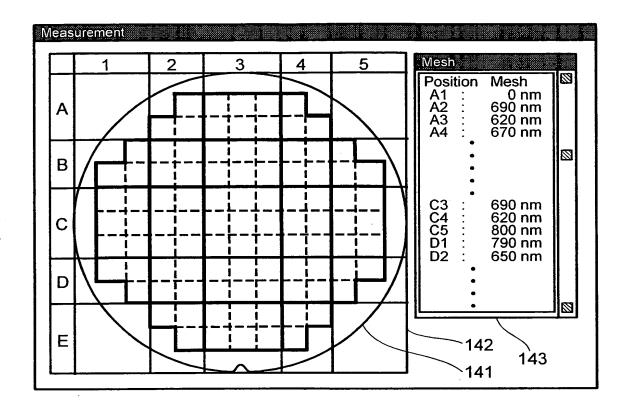


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**FIG.15** 



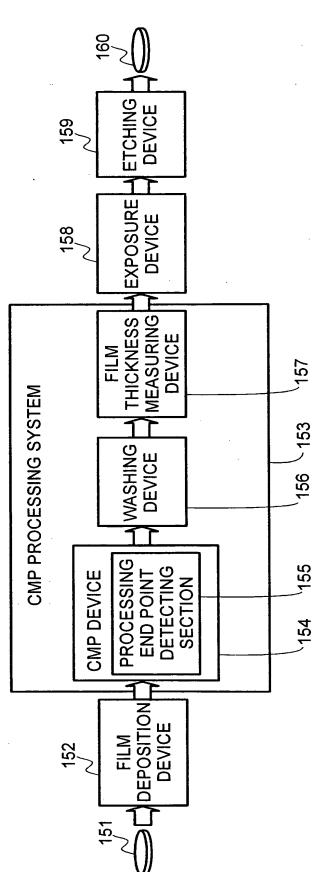
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